

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/667,694	VANDENTOP ET AL.	
	Examiner	Art Unit	Page 1 of 1
	Tuan T. Dinh	2841	

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*	C	US-6,084,781	07-2000	Klein, Dean A.	361/771
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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